


<b>Search Notes</b>  	<b>Application/Control No.</b>  10591279	<b>Applicant(s)/Patent Under Reexamination</b>  KOBAYASHI ET AL.
	<b>Examiner</b>  Jeffrey Lenihan	<b>Art Unit</b>  1765

SEARCHED			
Class	Subclass	Date	Examiner
525	191, 209, 241	9/17/2008	/JL/
525	102, 105, 191, 209, 342, 241, 50	3/25/2009	/JL/
526	178, 180, 335, 338, 340	3/25/2009	/JL/
152	905	3/25/2009	/JL/
525	102, 105, 191, 209, 236, 237, 241, 342, 50	3/21/2011	/JL/
526	278, 180, 335, 338, 340	3/21/2011	/JL/
152	905	3/21/2011	/JL/

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor Search in eDAN/PALM	9/17/2008	/JL/
Online NPL Search	9/17/2008	/JL/
See Attached EAST Search History	9/17/2008	/JL/
updated EAST search	3/25/2009	/JL/
updated EAST history	11/3/2009	/JL/
updated EAST search	3/21/2011	/JL/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
525	102, 105, 191, 209, 236, 237, 241, 342, 50	3/21/2011	/JL/
526	278, 180, 335, 338, 340	3/21/2011	/JL/
152	905	3/21/2011	/JL/
	see attached EAST history	3/21/2011	/JL/

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